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## 产品/机械

Materials characterisation & surface analysis specialising in ion beam analysis including SIMS, uleSIMS, RBS, Auger, XPS, RBS, FIB/TEM and surface contamination (TOF-SIMS, VPD-TXRF, VPD-ICPMS). Semiconductors, photovoltaics, optical coatings.

## Company Profile of Aystorm Scientific Ltd.

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